

N-Ch MOSFET

General Description

The WSF40N06A is the highest performance trench N-Ch MOSFET with extreme high cell density , which provide excellent RDSON and gate charge for most of the synchronous buck converter applications .

The WSF40N06A meet the RoHS and Green Product requirement, 100% EAS guaranteed with full function reliability approved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

Absolute Maximum Ratings

Product Summery

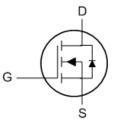
BVDSS	RDSON	ID
60V	20mΩ	50A

Applications

- High Frequency Point-of-Load Synchronous Buck Converter for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- LCD/LED back light

TO-252 Pin Configuration





Units Symbol **Parameter** Rating 60 V V_{DS} Drain-Source Voltage v ± 20 V_{GS} Gate-Source Voltage I_D@T_C=25℃ Continuous Drain Current, V_{GS} @ 10V¹ 50 А Continuous Drain Current, V_{GS} @ 10V¹ I_D@T_C=100℃ 32 А Continuous Drain Current, V_{GS} @ 10V¹ 10 A I_D@T_A=25℃ Continuous Drain Current, V_{GS} @ 10V¹ 8 I_D@T_A=70℃ А Pulsed Drain Current² 200 А **I**DM Single Pulse Avalanche Energy³ EAS 42 mJ Avalanche Current 28 А I_{AS} W P_D@T_C=25℃ Total Power Dissipation⁴ 53 Total Power Dissipation⁴ 3.5 w P_D@T_A=25℃ Storage Temperature Range -55 to 150 °C T_{STG} ΤJ **Operating Junction Temperature Range** -55 to 150 °C

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit	
R _{θJA}	Thermal Resistance Junction-Ambient ¹		62	°C/W	
R _{eJC}	Thermal Resistance Junction-Case ¹		2	°C/W	



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Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =250uA	60			V
$\triangle BV_{DSS} / \triangle T_J$	BV _{DSS} Temperature Coefficient	Reference to 25 $^\circ\!\mathrm{C}$, I_D=1mA		0.057		V/℃
_	Static Drain-Source On-Resistance ²	V _{GS} =10V , I _D =20A		20	23	
R _{DS(ON)}		V _{GS} =4.5V , I _D =10A		23	28	mΩ
V _{GS(th)}	Gate Threshold Voltage	—V _{GS} =V _{DS} , I _D =250uA	2.0	3.0	4.0	V
	V _{GS(th)} Temperature Coefficient			-5.68		mV/℃
		V_{DS} =48V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1	- uA
I _{DSS}	Drain-Source Leakage Current	V _{DS} =48V , V _{GS} =0V , T _J =55℃			5	
I _{GSS}	Gate-Source Leakage Current	$V_{GS}=\pm20V$, $V_{DS}=0V$			±100	nA
gfs	Forward Transconductance	V _{DS} =5V , I _D =15A		9		S
R _g	Gate Resistance	V _{DS} =0V , V _{GS} =0V , f=1MHz		1.7	3.4	Ω
Qg	Total Gate Charge (4.5V)	V _{DS} =30V , V _{GS} =4.5V , I _D =15A		28	36	
Q _{gs}	Gate-Source Charge			3.5	10	nC
Q _{gd}	Gate-Drain Charge			6.5	15	
T _{d(on)}	Turn-On Delay Time	V _{DD} =30V , V _{GS} =10V , R _G =3.3Ω, I _D =15A		7.2	14.4	
Tr	Rise Time			38	90	
T _{d(off)}	Turn-Off Delay Time			34	73	ns
T _f	Fall Time			8.2	15.2	
C _{iss}	Input Capacitance	V _{DS} =15V , V _{GS} =0V , f=1MHz		1680		
C _{oss}	Output Capacitance			115		pF
C _{rss}	Reverse Transfer Capacitance			85]

Guaranteed Avalanche Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
EAS	Single Pulse Avalanche Energy ⁵	V _{DD} =25V , L=0.1mH , I _{AS} =15A	19			mJ

Diode Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current ^{1,6}	$V_G = V_D = 0V$, Force Current			50	A
I _{SM}	Pulsed Source Current ^{2,6}				200	A
V _{SD}	Diode Forward Voltage ²	V _{GS} =0V , I _S =1A , T _J =25℃			1	V
t _{rr}	Reverse Recovery Time	IF=1A ,dl/dt=100A/µs,TJ=25℃		19.6		nS
Qrr	Reverse Recovery Charge			14.2		nC

Note :

1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper,t<10sec.

2.The data tested by pulsed , pulse width $\,\leq\,$ 300us , duty cycle $\,\leq\,$ 2%

3. The EAS data shows Max. rating . The test condition is $V_{\text{DD}}\text{=}25\text{V}, V_{\text{GS}}\text{=}10\text{V}, \text{L=}0.1\text{mH}, \text{I}_{\text{AS}}\text{=}15\text{A}$

4.The power dissipation is limited by 150 $^\circ\!\mathrm{C}$ $\,$ junction temperature

5. The Min. value is 100% EAS tested guarantee.

6. The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



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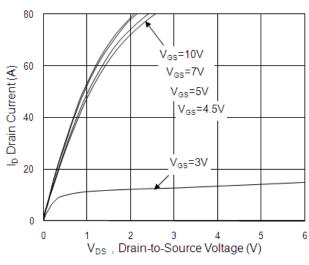
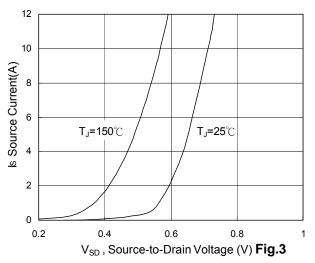


Fig.1 Typical Output Characteristics



Forward Characteristics of Reverse

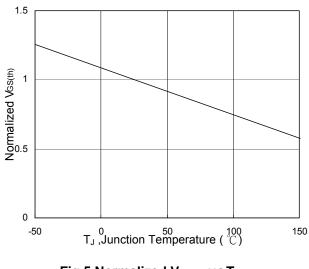


Fig.5 Normalized V_{GS(th)} v.s T_J

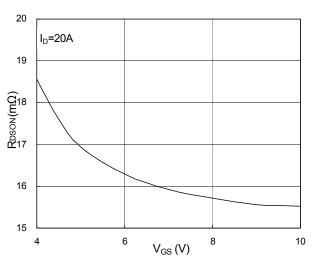


Fig.2 On-Resistance v.s Gate-Source

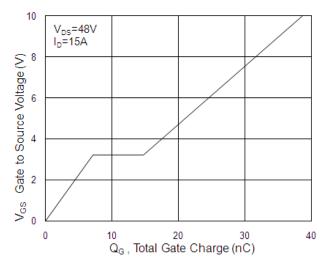
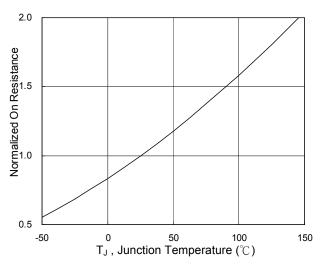
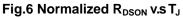


Fig.4 Gate-Charge Characteristics





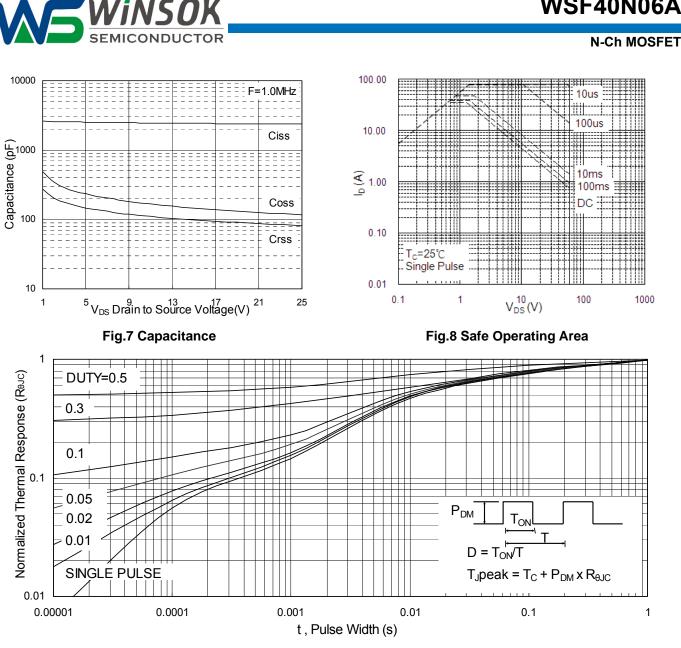
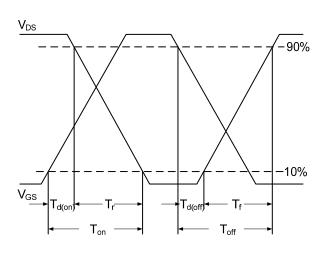
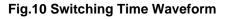


Fig.9 Normalized Maximum Transient Thermal Impedance





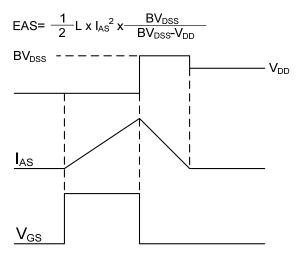


Fig.11 Unclamped Inductive Switching Waveform

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